

## Application Data Sheet

### Application Information

Applicant Type:: Regular  
Subject Matter:: Utility  
Suggested Classification::  
Suggested Group Art Unit::  
CD-ROM or CD-R?:: None  
Title:: Verfahren zur Messung von  
Kennwerten, insbesondere der  
Temperature eines  
mehrschichtigen Materials  
während des Schichtenaufbaus  
Attorney Docket Number:: 101215-75  
Request for Early Publication?:: No  
Request for Non-Publication?:: No  
Suggested Drawing Sheets::  
Total Drawing Sheets:: 5  
Small Entity:: Yes  
Petition included?::  
Secrecy Order in Parent Appl.?::

### Inventor Information

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## Application Data Sheet

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# Application Data Sheet

## Representative Information

Representative Customer Number:: 27387

## Domestic Priority Information

Application:: Continuity Type:: Parent Patent  
Application:: Filing Date::  
None

## Foreign Priority Information

Country:: Application Number:: Filing Date::  
Germany 100 61 168.0 November 30, 2000

## Assignee Information

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